

Notice of References Cited		Application/Control No. 10/010,974	Applicant(s)/Patent Under Reexamination SLICK ET AL.	
		Examiner David G. Cervetti	Art Unit 2136	Page 1 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,392,351	02-1995	Hasebe et al.	705/51
*	B	US-5,398,283	03-1995	Virga, Richard	380/243
*	C	US-5,720,012	02-1998	McVeigh et al.	358/1.14
*	D	US-5,933,498	08-1999	Schneck et al.	705/54
*	E	US-5,949,881	09-1999	Davis, Derek L.	713/189
*	F	US-5,953,419	09-1999	Lohstroh et al.	713/165
*	G	US-2002/0042884	04-2002	Wu et al.	713/201
*	H	US-2002/0080959	06-2002	Weller, Scott W.	380/55
*	I	US-6,473,508	10-2002	Young et al.	380/30
*	J	US-6,470,450	10-2002	Langford et al.	713/182
*	K	US-2003/0014640	01-2003	Loyd, Travis W.	713/182
*	L	US-6,694,434	02-2004	McGee et al.	713/189
*	M	US-6,711,677	03-2004	Wiegley, Rose E.	713/151

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Menezes et al., Handbook of Applied Cryptography, CRC Press, 1996, chapters 8-9 and 11, pp 283-383, 425-488.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/010,974	SLICK ET AL.	
Examiner		Art Unit		Page 2 of 5
David G. Cervetti		2136		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,392,351	02-1995	Hasebe et al.	705/51
*	B	US-5,970,147	10-1999	Davis, Derek L.	713/172
*	C	US-6,148,387 A	11-2000	Galasso et al.	711/203
*	D	US-2001/0021926	09-2001	SCHNECK et al.	705/54
*	E	US-2002/0016921	02-2002	Olsen et al.	713/200
*	F	US-6,353,888	03-2002	Kakehi et al.	713/168
*	G	US-6,370,247 B1	04-2002	Takaragi et al.	380/28
*	H	US-6,385,728 B1	05-2002	DeBry, Roger K.	726/9
*	I	US-2003/0044009	03-2003	Dathathraya, Sridhar	380/55
*	J	US-6,615,352	09-2003	Terao et al.	713/184
*	K	US-2003/0208691	11-2003	Smart et al.	713/201
*	L	US-6,862,583	03-2005	Mazzagatte et al.	705/64
*	M	US-6,918,042 B1	07-2005	Debry, Roger K.	726/5

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No. 10/010,974	Applicant(s)/Patent Under Reexamination SLICK ET AL.	
		Examiner David G. Cervetti	Art Unit 2136	Page 3 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,392,351 A	02-1995	Hasebe et al.	705/51
*	B	US-5,392,351 A	02-1995	Hasebe et al.	705/51
*	C	US-5,633,932 A	05-1997	Davis et al.	713/176
*	D	US-6,314,521 B1	11-2001	Debry, Roger K.	726/10
*	E	US-6,343,361 B1	01-2002	Nendell et al.	713/171
*	F	US-6,378,070 B1	04-2002	Chan et al.	713/155
*	G	US-6,480,831 B1	11-2002	Cordery et al.	705/60
*	H	US-2003/0074327 A1	04-2003	Meadow et al.	705/75
*	I	US-6,628,413 B1	09-2003	Lee, Kanghoon	358/1.15
*	J	US-6,711,680 B1	03-2004	Cordery, Robert A	713/176
*	K	US-6,971,007 B1	11-2005	Currans, Kevin G.	713/165
*	L	US-7,003,667 B1	02-2006	Slick et al.	713/182
*	M	US-7,020,781 B1	03-2006	Saw et al.	705/51

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/010,974	SLICK ET AL.	
Examiner		Art Unit		Page 4 of 5
David G. Cervetti		2136		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,029,137 A	02-2000	Cordery et al.	705/1
*	B	US-6,064,989 A	05-2000	Cordery et al.	705/50
*	C	US-6,144,950 A	11-2000	Davies et al.	705/401
*	D	US-6,178,412 B1	01-2001	Ratzenberger et al.	705/408
*	E	US-6,188,997 B1	02-2001	Ratzenberger et al.	705/410
*	F	US-6,965,996 B2	11-2005	Hirano et al.	713/176
*	G	US-6,978,017 B2	12-2005	Wiener et al.	380/30
*	H	US-7,020,773 B1	03-2006	Otway et al.	713/171
*	I	US-7,039,802 B1	05-2006	Eskicioglu et al.	713/156
*	J	US-7,062,651 B1	06-2006	Lapstun et al.	713/168
*	K	US-7,076,656 B2	07-2006	MacKenzie, Philip D.	713/171
*	L	US-7,073,073 B1	07-2006	Nonaka et al.	713/193
*	M	US-7,093,128 B2	08-2006	Asano et al.	713/171

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/010,974	SLICK ET AL.	
Examiner		Art Unit		Page 5 of 5
David G. Cervetti		2136		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,005,200 A	04-1991	Fischer, Addison M.	380/30
*	B	US-6,389,535 B1	05-2002	Thomlinson et al.	713/165
*	C	US-6,766,306 B1	07-2004	Matsuyama, Shinako	705/53
*	D	US-7,099,846 B1	08-2006	Ishibashi et al.	705/51
*	E	US-7,103,778 B2	09-2006	Kon et al.	713/185
F	US-				
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.